


<b>Search Notes</b> 	<b>Application/Control No.</b> 10633264	<b>Applicant(s)/Patent Under Reexamination</b> LEE ET AL.
	<b>Examiner</b> TRAN, MICHAEL T	<b>Art Unit</b> 2827

SEARCHED			
Class	Subclass	Date	Examiner
365	228	1/29/07	mt
365	226	1/29/07	mt

SEARCH NOTES		
Search Notes	Date	Examiner
east [see attached]	1/29/07	mt

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner